

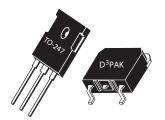
APT47N65BC3 APT47N65SC3

650V 47A 0.070Ω



Super Junction MOSFET

- Ultra low $R_{\rm DS(ON)}$
- Increased Power Dissipation
- Low Miller Capacitance
- ullet Ultra Low Gate Charge, $\mathbf{Q}_{\mathbf{q}}$
- Avalanche Energy Rated
- TO-247 or Surface Mount D3PAK Package





MAXIMUM RATINGS

All Ratings: $T_C = 25^{\circ}C$ unless otherwise specified.

| Symbol | Parameter | APT47N65B_SC3 | UNIT | |
|----------------------------------|----------------------------------------------------------------------------------------|---------------|-------|--|
| V _{DSS} | Drain-Source Voltage | 650 | Volts | |
| I _D | Continuous Drain Current @ T _C = 25°C | 47 | Amps | |
| I _{DM} | Pulsed Drain Current ¹ | 141 | 7 | |
| V _{GS} | Gate-Source Voltage Continuous | ±20 | Volts | |
| V_{GSM} | Gate-Source Voltage Transient | ±30 | | |
| P_D | Total Power Dissipation @ T _C = 25°C | 417 | Watts | |
| , D | Linear Derating Factor | 3.33 | W/°C | |
| T _J ,T _{STG} | Operating and Storage Junction Temperature Range | -55 to 150 | °C | |
| T _L | Lead Temperature: 0.063" from Case for 10 Sec. | 260 |] | |
| dv/ dt | Drain-Source Voltage slope ($V_{DS} = 480V$, $I_{D} = 47A$, $T_{J} = 125$ °C) | 50 | V/ns | |
| I _{AR} | Repetitive Avalanche Current ⁷ ++++Repetitive Avalanche Energy ⁷ | 20 | Amps | |
| E _{AR} | Single Pulse Avalanche Energy ⁴ | 1 | mJ | |
| E _{AS} | Single Pulse Avalanche Energy ⁴ | 1800 | | |

STATIC ELECTRICAL CHARACTERISTICS

| Symbol | Characteristic / Test Conditions | MIN | TYP | MAX | UNIT |
|---------------------|---------------------------------------------------------------------------------------|------|------|------|-------|
| BV _{DSS} | Drain-Source Breakdown Voltage ($V_{GS} = 0V$, $I_D = 250\mu A$) | 650 | | | Volts |
| R _{DS(on)} | Drain-Source On-State Resistance 2 ($V_{GS} = 10V$, $I_D = 30A$) | | 0.06 | 0.07 | Ohms |
| I _{DSS} | Zero Gate Voltage Drain Current (V _{DS} = 650V, V _{GS} = 0V) | | 0.5 | 25 | μΑ |
| | Zero Gate Voltage Drain Current ($V_{DS} = 650V$, $V_{GS} = 0V$, $T_{J} = 150$ °C) | | | 250 | |
| I _{GSS} | Gate-Source Leakage Current $(V_{GS} = \pm 20V, V_{DS} = 0V)$ | | | ±100 | nA |
| V _{GS(th)} | Gate Threshold Voltage $(V_{DS} = V_{GS}, I_D = 2.7\text{mA})$ | 2.10 | 3 | 3.9 | Volts |

CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

50-7202 Rev C

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| Symbol | Characteristic | Test Conditions | MIN | TYP | MAX | UNIT |
|---------------------|---------------------------------------|---------------------------------------------------------------------------|-----|------|------|------|
| C _{iss} | Input Capacitance | V _{GS} = 0V | | 6965 | 8355 | |
| C _{oss} | Output Capacitance | $V_{GS} = 25V$ | | 2100 | 2940 | pF |
| C _{rss} | Reverse Transfer Capacitance | f = 1 MHz | | 85 | 127 | , |
| Q_g | Total Gate Charge ³ | V _{GS} = 10V | | 250 | 375 | |
| Q_{gs} | Gate-Source Charge | V _{DD} = 300V | | 30 | 45 | nC |
| Q_{gd} | Gate-Drain ("Miller") Charge | I _D = 47A @ 25°C | | 105 | 157 | |
| t _{d(on)} | Turn-on Delay Time | INDUCTIVE SWITCHING | | 18 | 36 | |
| t _r | Rise Time | $V_{GS} = 13V$ $V_{DD} = 380V$ | | 28 | 56 | |
| t _{d(off)} | Turn-off Delay Time | I _D = 47A @ 125°C | | 295 | 442 | ns |
| t _f | Fall Time | $R_{G} = 5\Omega$ | | 84 | 168 | |
| E _{on} | Turn-on Switching Energy ⁶ | INDUCTIVE SWITCHING @ 25°C V _{DD} = 400V, V _{GS} = 15V | | 810 | 1620 | |
| E _{off} | Turn-off Switching Energy | $I_D = 47A, R_G = 5\Omega$ | | 840 | 1680 | |
| E _{on} | Turn-on Switching Energy ⁶ | INDUCTIVE SWITCHING @ 125°C V _{DD} = 400V V _{GS} = 15V | | 1172 | 1758 | μJ |
| E _{off} | Turn-off Switching Energy | $I_D = 47A, R_G = 5\Omega$ | | 985 | 1970 | |

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

| Symbol | Characteristic / Test Conditions | MIN | TYP | MAX | UNIT |
|-----------------------|----------------------------------------------------------------------------------|-----|-----|------|--------|
| Is | Continuous Source Current (Body Diode) | | | 47 | Amps |
| I _{SM} | Pulsed Source Current ¹ (Body Diode) | | | 141 | 741103 |
| V _{SD} | Diode Forward Voltage 2 ($V_{GS} = 0V$, $I_S = -47A$) | | | 1.2 | Volts |
| t _{rr} | Reverse Recovery Time ($I_S = -47A$, $dI_S/dt = 100A/\mu s$, $V_R = 350V$) | | 580 | 650 | ns |
| Q _{rr} | Reverse Recovery Charge ($I_S = -47A$, $dI_S/dt = 100A/\mu s$, $V_R = 350V$) | | 23 | 16.5 | μC |
| dv _/ dt | Peak Diode Recovery ^{dv} / _{dt} ⁵ | | | 6 | V/ns |

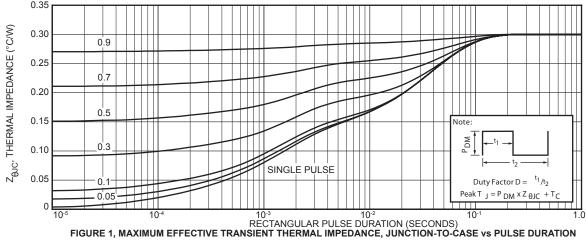
THERMAL CHARACTERISTICS

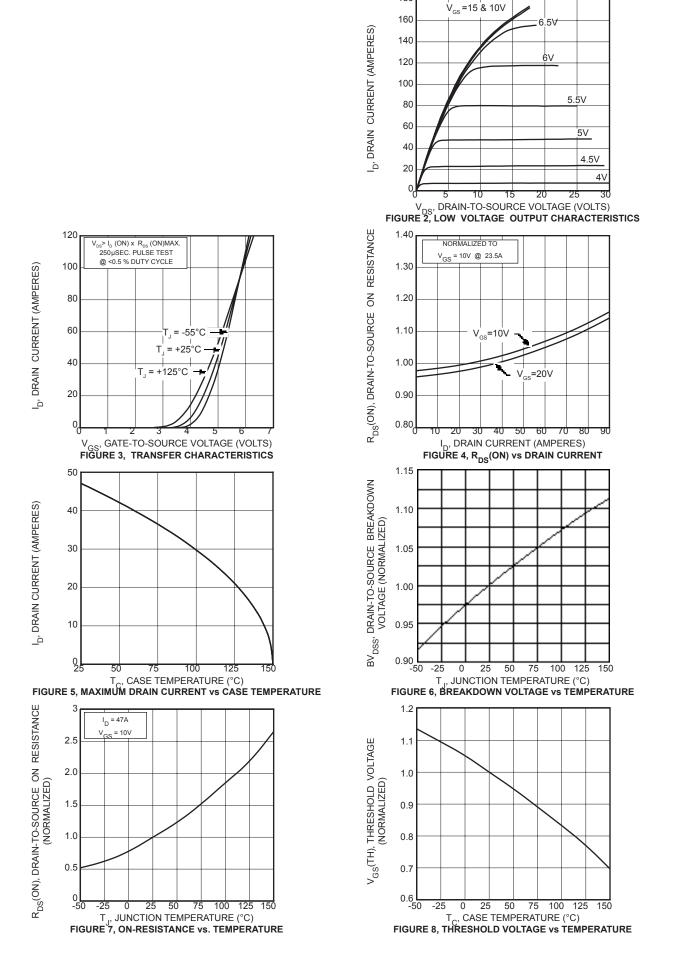
| Symbol | Characteristic | MIN | TYP | MAX | UNIT |
|-----------------|---------------------|-----|-----|------|----------------------|
| $R_{\theta JC}$ | Junction to Case | | | 0.30 | °C/W |
| $R_{\theta JA}$ | Junction to Ambient | | | 62 | <i>5/</i> V I |

- ① Repetitive Rating: Pulse width limited by maximum junction temperature
- 2 Pulse Test: Pulse width < 380 µs, Duty Cycle < 2%
- 3 See MIL-STD-750 Method 3471

- Starting T_j = +25°C, L = 36.0mH, R_G = 25Ω, Peak I_L = 10A
 dv/_{dt} numbers reflect the limitations of the test circuit rather than the device itself. I_S = -I_D47A, di/_{dt} = 700A/μs v_R = v_{DSS}, T_J = 150°C
 Eon includes diode reverse recovery. See figures 18, 20.
- Repetitve avalanche causes additional power losses that can be

calculated as P_{AV} = E_{AR} *f Microsemi Reserves the right to change, without notice, the specifications and information contained herein.





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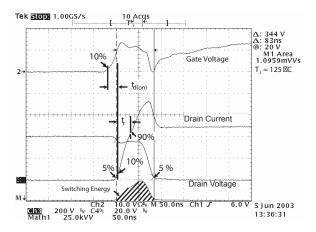


Figure 18, Turn-on Switching Waveforms and Definitions

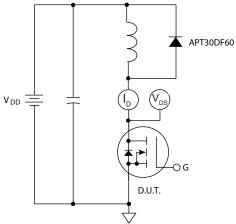
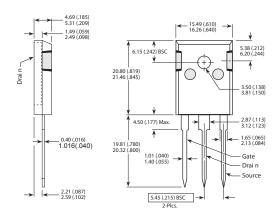


Figure 20, Inductive Switching Test Circuit

Tek Stop: 1.00GS/s 11 Acqs A: 48.4 V A: 388ns @- 400mV M1 Area 1.2055mVVS T = 125 🖾 C Ch3 200 V % C12 0.0 V V M 50.0ns Ch1 6.0 V M1 Ch2 25.0kVV 50.0ns Ch3 200 V % C12 20.0 V % 50.0ns 13:32:58

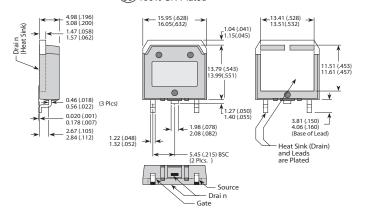
Figure 19, Turn-off Switching Waveforms and Definitions

TO-247 Package Outline



D³PAK (S) Package Outline

(3) 100% SN Plated



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